

	Class	Subclass
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PATENT NUMBER

U.S. UTILITY Patent Application

O.I.P.E.	PATENT DATE
TR. 115 ³ Q.A. 1A	

APPLICATION NO. 09/732393	CONT/PRIOR F	CLASS 382 252-	SUBCLASS 1A9	ART UNIT 2811.2633	EXAMINER J. M. M. A. S. D.
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Kunihiko Take

Virginia Kibler

Semiconductor wafer examination system

PTO-2040
12/89

ISSUING CLASSIFICATION

[illegible]

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